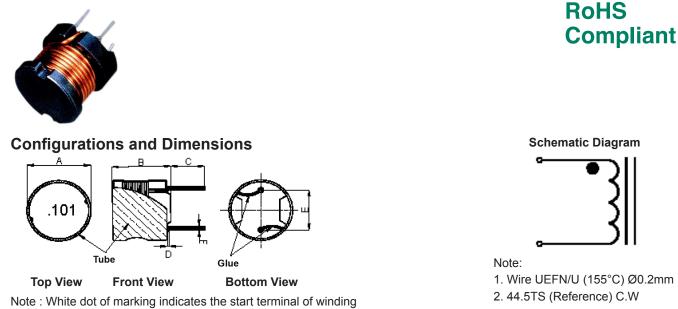
Inductor **Radial Leaded**



Test Data for Mechanical

Test Item	A mm	B mm	C mm	D mm	E mm	F mm
Specification	8 ±0.5	5.5 ±0.5	5 ±1	1 (Max.)	5 ±0.5	Ø0.65 (Ref.)
1	8.04	5.72	4.92	0.64	5.04	0.64
2	8.05	5.68	5.03	0.62	5.08	0.63
3	8.04	5.65	5.08	0.67	5.08	0.64
4	8.05	5.72	4.97	0.72	5.07	0.63
5	8.05	5.68	4.98	0.68	5.05	0.64
Average	8.05	5.69	5	0.67	5.06	0.64

Electrical Characteristics

Test Condition		
1kHz 0.25V	L	100µH ±10%
TA = 25°C	DCR	1Ω (Max.)
1kHz 0.25V Irms = 1.1A	ΔΤ	Temperature rise 40°C (Max.)

Operating temperature : -55°C to +130°C

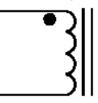
Material List

No.	ltem	Material Description
1	Core	DL5 DR4W 10 × 10 RSN B4.5 F5
2	Wire	Ø0.45mm × 2 UEFN/U (155°C)
3	Solder (Lead-free)	Sn99.3% / Cu0.7%
4	Tube	CB-HFT
5	Glue	6020H-4

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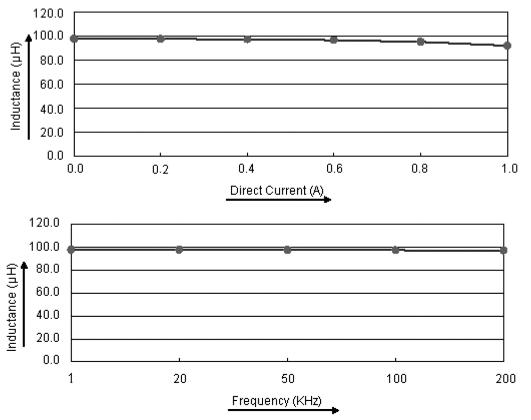
1. Wire UEFN/U (155°C) Ø0.2mm 2. 44.5TS (Reference) C.W

Inductor Radial Leaded

Reliability Test

Test Item	Specifications		Test Method and Remarks	
Operating temperature range	-55°C to +130°C		Including temperature	rise due to self-generated heat.
Storage condition	Ambient temperature: 0°C to 40°CHumidity: Below 70% RH		To maintain the solderability of terminal electrodes, care must be taken to control temperature and humidity in the storage area.	
Moisture sensitivity	Appearance DCR change Inductance change	: No abnormality No damage : Within ±5% : Within ±5%	According to J-STD-02 Test condition Test duration Recovery	 0B level 3 : 60°C 60% RH : 40 hrs : 1 to 2 hours of recovery under the standard condition after the removal from the test chamber.
Solderability	All termination shall exhibit a continuous solder coating free from defects for a minimum of 95% of the surface area of any individual lead.		According to J-STD-00 Steam aging category Steam aging duration Solder Solder temperature Dip time	: 97°C 98% RH

Electric Characteristics



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Test Data for Electrical

Test Item	L µH	DCR Ω	ΔΤ
Condition	1kHz 0.25V	at 25°C	1kHz 0.25V Irms = 1.1A
Specification	100 ±10%	1 (Max.)	Temperature rise 40°C (Max.)
1	98.06	0.42	
2	96.5	0.43	
3	98.04	0.42	OK
4	96.66	0.42	
5	99.08	0.42	
Average	97.67	0.42	ОК

Part Number Table

Description	Part Number	
Inductor, 100µH, 10%, Radial Leaded	MCSCH855U-101KU	

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